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Patent

Customer No. 31561
Docket No. 10573-US-PA
Application No.: 10/604,793

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of

Applicant : Rui-Hui Wen
Application No. : 10/604,793
Filed : August 18, 2003
For : ION SAMPLING SYSTEM FOR WAFER AND SAMPLING
METHOD THEREOF
Examiner : TBA
Art Unit : 1746

INFORMATION DISCLOSURE STATEMENT

002-1-571-273-8300

(Via fax: 2+11 pages)

United States Patent and Trademark Office
Customer Service Window, Mail Stop Amendment
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Enclosed is a PTO Form 1449 listing 1 reference, copy of which is attached. Applicant submits the reference in compliance with their duty of disclosure pursuant to 37 CFR § 1.56 and 1.97. The Examiner is requested to make the citation of official record.

This IDS is being submitted before the first Office Action. Thus, it is believed no fee is due.

The submission of the reference should not be interpreted as admitting them as prior art.

Respectfully Submitted,
JIANQ CHYUN Intellectual Property Office

Date: Oct. 31, 2005

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FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE INFORMATION DISCLOSURE STATEMENT BY APPLICATION	ATTY. DOCKET NO.: 10573-US-PA	APPLICATION NO.: 10/604,793
	APPLICANT: Rui-Hui Wen	
	FILING DATE: August 18, 2003	GROUP 1746

U.S. PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE)

FOREIGN PATENT DOCUMENTS						
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	FILING DATE (IF APPROPRIATE) June 24, 1998
	2000-005710	January 11, 2000	Japan			

EXAMINER INITIAL	OTHER DOCUMENTS (INCLUDING AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC.)

EXAMINER	DATE CONSIDERED
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EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED. INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.